







SN54AHC240, SN74AHC240

## SCLS251I - OCTOBER 1995 - REVISED APRIL 2023

## **SNx4AHC240 Octal Buffers/Drivers With 3-State Outputs**

#### 1 Features

- V<sub>CC</sub> operation of 2 V to 5.5 V
- Latch-up performance exceeds 250 mA per JESD

## 2 Applications

- Handset: Smartphone
- **Network Switch**
- Health and Fitness / Wearables

## 3 Description

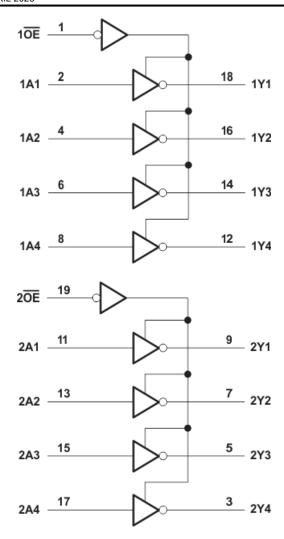
These octal buffers/drivers are designed specifically to improve the performance and density of 3-state memory-address drivers, clock drivers, and busoriented receivers and transmitters.

#### Package Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	J (CDIP, 20)	24.2 mm × 6.92 mm
SN54AHC240	W (CFP, 20)	13.09 mm × 6.92 mm
	FK (LCCC, 20)	8.89 mm × 8.89 mm
	N (PDIP, 20)	24.33 mm × 6.35 mm
SN74AHC240	DW (SOIC, 20)	12.8 mm × 7.5 mm
3N/4AHC240	NS (SOP, 20)	12.6 mm × 5.30 mm
	PW (TSSOP, 20)	6.5 mm × 4.40 mm

For all available packages, see the orderable addendum at the end of the data sheet.





**Logic Diagram (Positive Logic)** 



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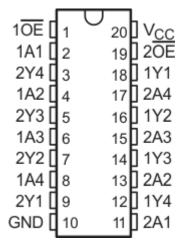
## **4 Revision History**

## Changes from Revision H (July 2003) to Revision I (April 2023)

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## **5 Pin Configuration and Functions**



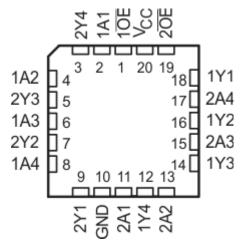


Figure 5-1. SN54AHC240 J or W Package; SN74AHC240 DB, DGV, DW, N, NS, or PW Package (Top View)

Figure 5-2. SN54AHC240 FK Package (Top View)

PIN	1/0	DESCRIPTION
1	10E	Output enable 1
2	1A1	1A1 input
3	2Y4	2Y4 output
4	1A2	1A2 input
5	2Y3	2Y3 output
6	1A3	1A3 input
7	2Y2	2Y2 output
8	1A4	1A4 input
9	2Y1	2Y1 output
10	GND	Ground pin
11	2A1	2A1 input
12	1Y4	1Y4 output
13	2A2	2A2 input
14	1Y3	1Y3 output
15	2A3	2A3 input
16	1Y2	1Y2 output
17	2A4	2A4 input
18	1Y1	1Y1 output
19	2OE	Output enable 2
20	VCC	Power pin



## **6 Specifications**

## **6.1 Absolute Maximum Ratings**

over operating free-air temperature (unless otherwise noted) (1)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		-0.5	7	V
VI	Input voltage <sup>(2)</sup>		-0.5	7	V
Vo	Output voltage <sub>(2)</sub>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$ )		±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±25	mA
	Continuous current through V <sub>CC</sub> or GN	ID .		±75	mA
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

				VALUE	UNIT
Γ,	·/	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
	V <sub>(ESD)</sub> dis	discharge Charged-device model	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±2000	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

<sup>(2)</sup> The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## **6.3 Recommended Operating Conditions**

see (Note 1)

			SN54AHC	240	SN74AH	C240	LINUT
			MIN	MAX	MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		2	5.5	2	5.5	V
		V <sub>CC</sub> = 2 V	1.5		1.5		
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 3 V	2.1		2.1		V
		V <sub>CC</sub> = 5.5 V	3.85		3.85		
		V <sub>CC</sub> = 2 V		0.5		0.5	
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 3 V		0.9		0.9	V
		V <sub>CC</sub> = 5.5 V		1.65		1.65	
VI	Input voltage	·	0	5.5	0	5.5	V
Vo	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 2 V		-50		-50	μA
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 3.3 V ± 0.3 V		-4		-4	mA
		V <sub>CC</sub> = 5 V ± 0.5 V		-8		-8	MA
		V <sub>CC</sub> = 2 V		50		50	μA
$I_{OL}$	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4		4	Л
		V <sub>CC</sub> = 5 V ± 0.5 V		8		8	mA
۸ + / ۸ ، ,	Input transition rise or fall rate	V <sub>CC</sub> = 3.3 V ± 0.3 V		100		100	20/1
Δt/Δv	Input transition rise or fall rate	V <sub>CC</sub> = 5 V ± 0.5 V		20		20	ns/V
T <sub>A</sub>	Operating free-air temperature	,	-55	125	-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, SCBA004.

### **6.4 Thermal Information**

THERMAL METRIC(1)		DW	DB	DGV	N	NS	PW	UNIT
		20 PINS					ONT	
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	58	70	92	69	60	83	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



#### 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	TA	\ = 25°C		SN54AH	C240	SN74AHC240		UNIT
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
		2 V	1.9	2		1.9		1.9		
	$I_{OH} = -50 \mu A$	3 V	2.9	3		2.9		2.9		
V <sub>OH</sub>		4.5 V	4.4	4.5		4.4		4.4		V
	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		2.48		
	I <sub>OH</sub> = -8 mA	4.5 V	3.94			3.8		3.8		
		2 V			0.1		0.1		0.1	
	I <sub>OL</sub> = 50 μA	3 V			0.1		0.1		0.1	V
V <sub>OL</sub>		4.5 V			0.1		0.1		0.1	
	I <sub>OL</sub> = 4 mA	3 V			0.36		0.5	,	0.44	
	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.5		0.44	
I <sub>I</sub>	V <sub>I</sub> = 5.5 V or GND	0 V to 5.5 V			± 0.1		± 1 <sub>1</sub>		± 1	μΑ
I <sub>OZ 2</sub>	$V_O = V_{CC}$ or GND, $V_I (\overline{OE}) = V_{IL}$ or $V_{IH}$	5.5 V			± 0.25		± 2.5		± 2.5	μΑ
Icc	V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0	5.5 V			4		40		40	μΑ
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		2.5	10				10	pF
Co	$V_O = V_{CC}$ or GND	5 V		3.5						pF

- 1. On products compliant to MIL-PRF-38535, this parameter is not production tested at  $V_{CC} = 0 \text{ V}$ .
- 2. The parameter I<sub>OZ</sub> includes the input leakage current.

## 6.6 Switching Characteristics, V<sub>CC</sub> = 3.3 V ±0.3 V

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM	то	LOAD	T	= 25°C		SN54Al	1C240	SN74AH	C240	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII	
t <sub>PLH</sub>	Α	Y	C <sub>L</sub> = 15 pF		5.3(1)	7.5(1)	1(1)	9(1)	1	9	no	
t <sub>PHL</sub>		Ī	CL = 15 pr		5.3(1)	7.5(1)	1(1)	9(1)	1	9	ns	
t <sub>PZH</sub>	ŌĒ	Y	C <sub>L</sub> = 15 pF		6.6(1)	10.6(1)	1(1)	12.5(1)	1	12.5	ns	
t <sub>PZL</sub>	OL	Ţ	C <sub>L</sub> = 15 pr		6.6(1)	10.6(1)	1(1)	12.5(1)	1	12.5	115	
t <sub>PHZ</sub>	ŌĒ	Y	C <sub>L</sub> = 15 pF		7.8(1)	11.5(1)	1(1)	12.5(1)	1	12.5	no	
t <sub>PLZ</sub>	ŌĒ	Ī	CL = 15 pr		7.8(1)	11.5(1)	1(1)	12.5(1)	1	12.5	ns	
t <sub>PLH</sub>	Α	Y	C <sub>L</sub> = 50 pF		7.8	11	1	12.5	1	12.5	no	
t <sub>PHL</sub>		Ī	CL = 50 pr		7.8	11	1	12.5	1	12.5	ns	
t <sub>PZH</sub>	ŌĒ	Y	C <sub>1</sub> = 50 pF		9.1	14.1	1	16	1	16	ns	
t <sub>PZL</sub>	OE .	Ī	C <sub>L</sub> = 50 pr		9.1	14.1	1	16	1	16	115	
t <sub>PHZ</sub>	ŌĒ.	Y	C = 50 pF		10.3	14	1	16	1	16	20	
t <sub>PLZ</sub>	OE	OE	f	C <sub>L</sub> = 50 pF		10.3	14	1	16	1	16	ns
t <sub>sk(o)</sub>			C <sub>L</sub> = 50 pF			1.5 <sup>(2)</sup>				1.5	ns	

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>(2)</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.



## 6.7 Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM TO		LOAD	T	= 25°C		SN54AH	IC240	SN74AHC240		UNIT	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII	
t <sub>PLH</sub>	Α	Y	C <sub>L</sub> = 15 pF		3.6(1)	5.5(1)	1(1)	6.5(1)	1	6.5(1)	ns	
t <sub>PHL</sub>	_ ^	1	OL = 13 pr		3.6(1)	5.5(1)	1(1)	6.5(1)	1	6.5(1)	115	
t <sub>PZH</sub>	ŌĒ	Y	C <sub>L</sub> = 15 pF		4.7(1)	7.3(1)	1(1)	8.5(1)	1	8.5	no	
t <sub>PZL</sub>	OE.	Ī	CL = 15 pr		4.7(1)	7.3(1)	1(1)	8.5(1)	1	8.5	ns	
t <sub>PHZ</sub>	ŌĒ	Y	C <sub>L</sub> = 15 pF		5.2(1)	7.2(1)	1(1)	8.5(1)	1	8.5	no	
t <sub>PLZ</sub>		OE .	Ī	CL = 15 pr		5.2(1)	7.2(1)	1(1)	8.5(1)	1	8.5	ns
t <sub>PLH</sub>	Α	Y	C <sub>L</sub> = 50 pF		5.1	7.5	1	8.5	1	8.5	ns	
t <sub>PHL</sub>		Ţ	C <sub>L</sub> = 50 pF	CL = 30 pr		5.1	7.5	1	8.5	1	8.5	115
t <sub>PZH</sub>	ŌĒ	Y	C <sub>L</sub> = 50 pF		6.2	9.3	1	10.5	1	10.5	no	
t <sub>PZL</sub>	OE .	Ī	CL = 50 pr		6.2	9.3	1	10.5	1	10.5	ns	
t <sub>PHZ</sub>	ŌĒ	Y	C <sub>L</sub> = 50 pF		6.7	9.2	1	10.5	1	10.5	ne	
t <sub>PLZ</sub>	OE	ſ	OL – 30 PF		6.7	9.2	1	10.5	1	10.5	ns	
t <sub>sk(o)</sub>			C <sub>L</sub> = 50 pF			1 <sup>(2)</sup>				1	ns	

<sup>(1)</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

<sup>(2)</sup> On products compliant to MIL-PRF-38535, this parameter does not apply.



## **6.8 Noise Characteristics**

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}\text{C (see (Note 1))}$ 

	PARAMETER	MIN	TYP	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.6		
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>		-0.6		
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>		4.6		V
V <sub>IH(D)</sub>	High-level dynamic input voltage	3.5			
V <sub>IL(D)</sub>	Low-level dynamic input voltage			1.5	

<sup>(1)</sup> Characteristics are for surface-mount packages only.

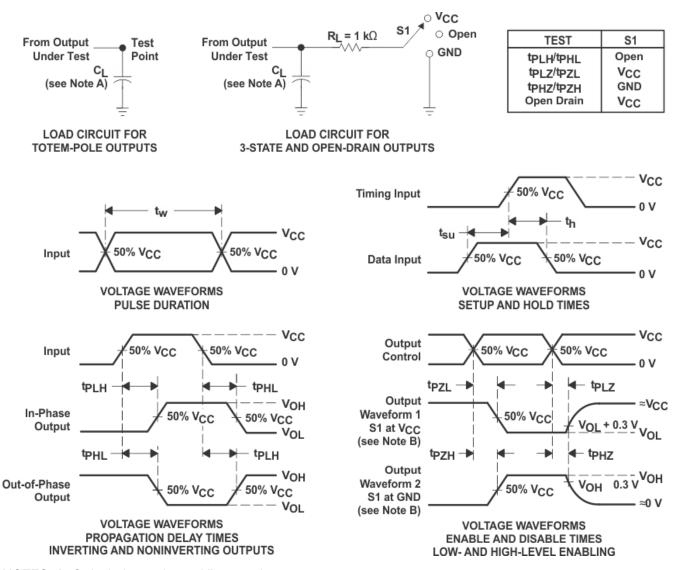
## **6.9 Operating Characteristics**

 $V_{CC}$  = 5 V,  $T_A$  = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load, f = 1 MHz	10	pF



#### 7 Parameter Measurement Information



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O$  = 50  $\Omega$ ,  $t_r \leq$  3 ns,  $t_f \leq$  3 ns.
- D. The outputs are measured one at a time with one input transition per measurement. E. All parameters and waveforms are not applicable to all devices.

Figure 7-1. Load Circuit and Voltage Waveforms



## **8 Detailed Description**

### 8.1 Overview

The 'AHC240 devices are organized as two 4-bit buffers/line drivers with separate output-enable ( $\overline{OE}$ ) inputs. When  $\overline{OE}$  is low, the device passes data from the A inputs to the Y outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

#### 8.2 Functional Block Diagram

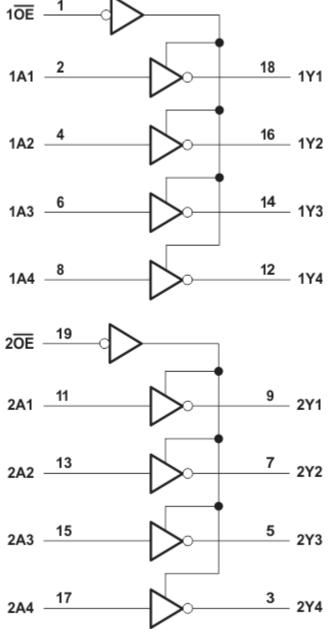


Figure 8-1. Logic Diagram (Positive Logic)



#### 8.3 Device Functional Modes

Table 8-1. Function Table (Each Buffer)

INPU	OUTPUT (2)	
ŌĒ	Α	Y
L	Н	L
L	L	Н
Н	Х	Z

- (1) H = High Voltage Level, L = Low Voltage Level, X = Don't Care
- (2) H = Driving High, L = Driving Low, Z = High Impedance State



## 9 Application and Implementation

#### **Note**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 9.1 Power Supply Recommendations

The power supply can be any voltage between the min and max supply voltage rating located in Section 6.3.

Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends 0.1  $\mu$ F and if there are multiple  $V_{CC}$  terminals, then TI recommends .01  $\mu$ F or .022  $\mu$ F for each power terminal. It is okay to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1  $\mu$ F and 1  $\mu$ F are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

#### 9.2 Layout

#### 9.2.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$  whichever make more sense or is more convenient. It is generally okay to float outputs unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This does not disable the input section of the IOs so they cannot float when disabled.

#### 9.2.1.1 Layout Example

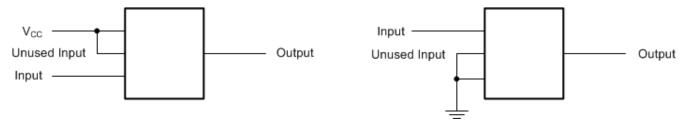


Figure 9-1. Layout Recommendation

## 10 Device and Documentation Support

### **10.1 Documentation Support**

#### 10.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 10-1. Related Links

PARTS	PRODUCT FOLDER	PRODUCT FOLDER SAMPLE & BUY DO		TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
SN54AHC240	Click here	Click here	Click here	Click here	Click here	
SN74AHC240	Click here	Click here	Click here	Click here	Click here	

#### 10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 10.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 10.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

#### 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

11-May-2023 www.ti.com

#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9680701Q2A	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9680701Q2A SNJ54AHC 240FK	Samples
5962-9680701QRA	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9680701QR A SNJ54AHC240J	Samples
5962-9680701QSA	ACTIVE	CFP	W	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9680701QS A SNJ54AHC240W	Samples
SN74AHC240DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AHC240	Samples
SN74AHC240N	ACTIVE	PDIP	N	20	20	RoHS & Non-Green	NIPDAU	N / A for Pkg Type	-40 to 85	SN74AHC240N	Samples
SN74AHC240NSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AHC240	Samples
SN74AHC240PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	HA240	Samples
SNJ54AHC240FK	ACTIVE	LCCC	FK	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9680701Q2A SNJ54AHC 240FK	Samples
SNJ54AHC240J	ACTIVE	CDIP	J	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9680701QR A SNJ54AHC240J	Samples
SNJ54AHC240W	ACTIVE	CFP	W	20	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9680701QS A SNJ54AHC240W	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

## PACKAGE OPTION ADDENDUM

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(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54AHC240, SN74AHC240:

Catalog: SN74AHC240

Military: SN54AHC240

NOTE: Qualified Version Definitions:

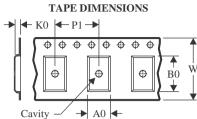
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

## **PACKAGE MATERIALS INFORMATION**

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### TAPE AND REEL INFORMATION





	•
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

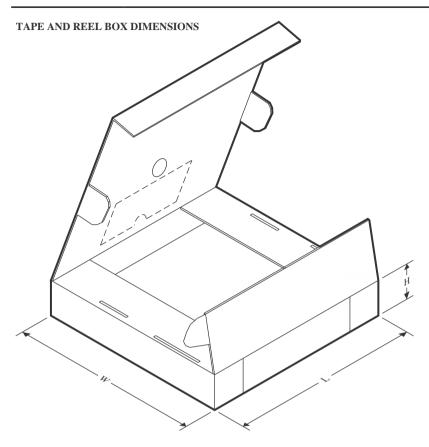


#### \*All dimensions are nominal

	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
l	SN74AHC240DWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
Γ	SN74AHC240NSR	so	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
L	SN74AHC240PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1



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### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC240DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74AHC240NSR	SO	NS	20	2000	367.0	367.0	45.0
SN74AHC240PWR	TSSOP	PW	20	2000	356.0	356.0	35.0

## **PACKAGE MATERIALS INFORMATION**

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### **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9680701Q2A	FK	LCCC	20	1	506.98	12.06	2030	NA
5962-9680701QSA	W	CFP	20	1	506.98	26.16	6220	NA
SN74AHC240N	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54AHC240FK	FK	LCCC	20	1	506.98	12.06	2030	NA
SNJ54AHC240W	W	CFP	20	1	506.98	26.16	6220	NA

## **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



## N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# W (R-GDFP-F20)

## CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.

  D. Index point is provided on cap for terminal identification only.

  E. Falls within Mil—Std 1835 GDFP2—F20





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# PW (R-PDSO-G20)

## PLASTIC SMALL OUTLINE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
  C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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